BFR740L3RH



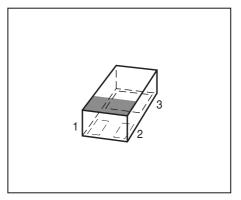
NPN Silicon Germanium RF Transistor

- High gain ultra low noise RF transistor
- Extremly small and flat leadless package, height 0.32 mm, ideal for modules
- Provides outstanding performance for wireless applications up to 10 GHz
- Ideal for WLAN applications, including routers and access points
- Based on Infineon's reliable high volume SiGe:C technology
- Outstanding noise figure NF_{min} 0.5 dB at 1.8 GHz
 Outstanding noise figure NF_{min} 0.8 dB at 6 GHz
- Accurate SPICE GP model enables effective design in process
- High maximum stable and available gain Gms = 24.5 dB at 1.8 GHz, Gma = 15 dB at 6 GHz
- Pb-free (RoHS compliant) package



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration			Package
BFR740L3RH	R9	1=B	2=C	3=E	TSLP-3-9





Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CEO}		V
$T_{A} > 0^{\circ}C$		4	
$T_{A} \leq 0^{\circ}C$		3.5	
Collector-emitter voltage	V _{CES}	13	
Collector-base voltage	V _{CBO}	13	
Emitter-base voltage	V _{EBO}	1.2	
Collector current	I _C	30	mA
Base current	I _B	3	
Total power dissipation ¹⁾	P _{tot}	160	mW
<i>T</i> _S ≤ 99°C			
Junction temperature	TJ	150	
Ambient temperature	T _A	-65 150	
Storage temperature	T _{Stg}	-65 150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ²⁾	R _{thJS}	≤ 320	K/W

 ${}^1\mathcal{T}_S$ is measured on the emitter lead at the soldering point to the pcb

²For calculation of R_{thJA} please refer to Application Note AN077 Thermal Resistance

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

Parameter	Symbol		Values		
		min.	typ.	max.]
DC Characteristics			•		
Collector-emitter breakdown voltage	V _{(BR)CEO}	4	4.7	-	V
<i>I</i> _C = 1 mA, <i>I</i> _B = 0					
Collector-emitter cutoff current	I _{CES}				μA
$V_{\rm CE}$ = 13 V, $V_{\rm BE}$ = 0		-	-	30	
$V_{\rm CE}$ = 5 V, $V_{\rm BE}$ = 0		-	0.001	0.04	
Collector-base cutoff current	I _{CBO}	-	1	40	nA
$V_{\rm CB} = 5 \text{V}, I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	-	10	900	
$V_{\rm EB}$ = 0.5 V, $I_{\rm C}$ = 0					
DC current gain	h _{FE}	160	250	400	-
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, pulse measured					



Parameter	Symbol		Values		
		min.	typ.	max.	
AC Characteristics (verified by random sampling	g)	1	1		
Transition frequency	f _T	-	42	-	GHz
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, f = 2 GHz					
Collector-base capacitance	C _{cb}	-	0.09	0.15	pF
$V_{CB} = 3 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
emitter grounded					
Collector emitter capacitance	C _{ce}	-	0.18	-	
$V_{CE} = 3 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
base grounded					
Emitter-base capacitance	C _{eb}	-	0.38	-	
$V_{\rm EB}$ = 0.5 V, <i>f</i> = 1 MHz, $V_{\rm CB}$ = 0 ,					
collector grounded					
Minimum noise figure	NF _{min}				dB
$I_{\rm C}$ = 8 mA, $V_{\rm CE}$ = 3 V, f = 1.8 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	0.5	-	
$I_{\rm C}$ = 8 mA, $V_{\rm CE}$ = 3 V, f = 6 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	0.8	-	
Power gain, maximum stable ¹⁾	G _{ms}	-	24.5	-	dB
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$,					
$Z_{\rm L} = Z_{\rm Lopt}$, $f = 1.8 {\rm GHz}$					
Power gain, maximum available ¹⁾	G _{ma}	-	15	-	dB
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$,					
$Z_{\rm L} = Z_{\rm Lopt}, f = 6 {\rm GHz}$					
Transducer gain	S _{21e} ²				dB
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω,					
<i>f</i> = 1.8 GHz		-	22	-	
<i>f</i> = 6 GHz		-	12.5	-	
Third order intercept point at output ²⁾	IP ₃	-	25	-	dBm
V_{CE} = 3 V, I_{C} = 25 mA, Z_{S} = Z_{L} =50 Ω , f = 1.8 GHz					
1dB compression point at output	P _{-1dB}	-	11	-	
$I_{\rm C}$ = 25 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ =50 Ω , f = 1.8 GHz					

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

 ${}^{1}G_{\rm ma} = |S_{21\rm e} \,/\, S_{12\rm e}| \; (k \cdot (k^2 \cdot 1)^{1/2}), \; G_{\rm ms} = |S_{21\rm e} \,/\, S_{12\rm e}|$

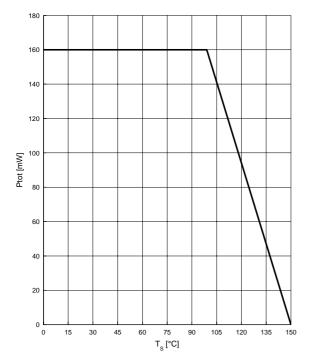
²IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is 50Ω from 0.1 MHz to 6 GHz



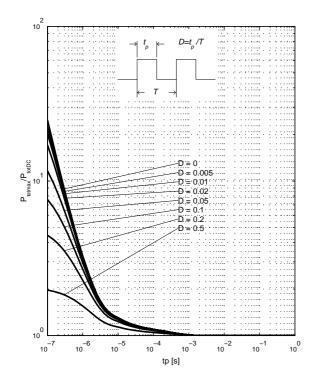
Total power dissipation $P_{tot} = f(T_S)$

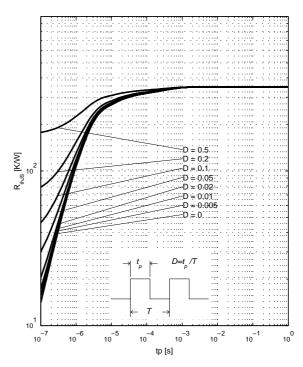
Permissible Puls Load $R_{thJS} = f(t_p)$



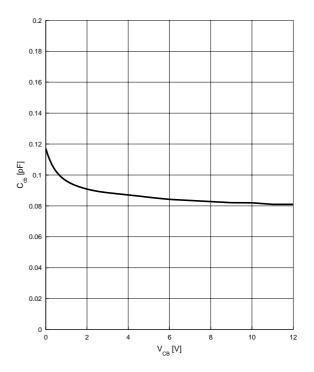
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{\text{p}})$





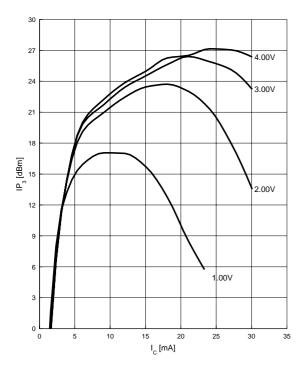
Collector-base capacitance $C_{cb} = f (V_{CB})$ f = 1 MHz



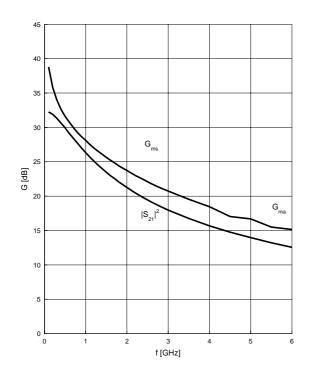


Third order Intercept Point $IP_3 = f(I_C)$

(Output, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω) $V_{\rm CE}$ = parameter, f = 1.8 GHz

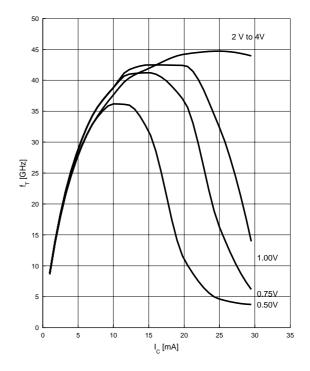


Power gain G_{ma} , $G_{ms} = f(f)$ $V_{CE} = 3 \text{ V}$, $I_C = 25 \text{ mA}$

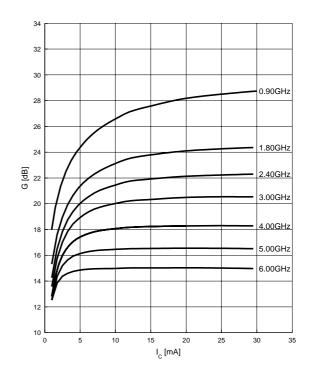


Transition frequency $f_{\rm T} = f(I_{\rm C})$

 V_{CE} = parameter, f = 2 GHz



Power gain G_{ma} , $G_{ms} = f(I_C)$ $V_{CE} = 3 \vee$ f = parameter

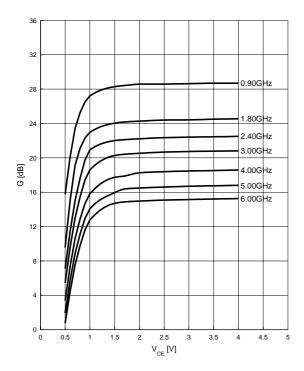


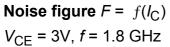


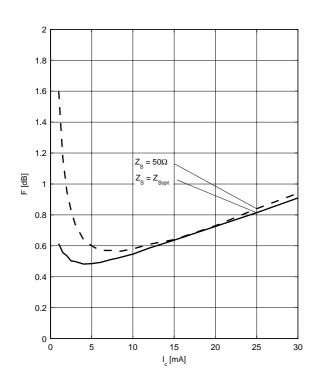
Power gain G_{ma} , $G_{ms} = f(V_{CE})$

*I*_C = 25 mA

f = parameter



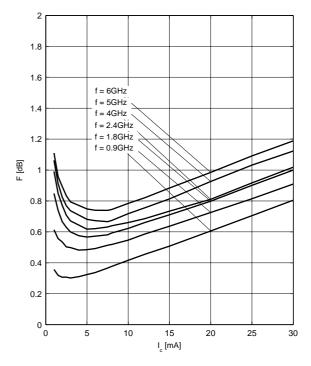




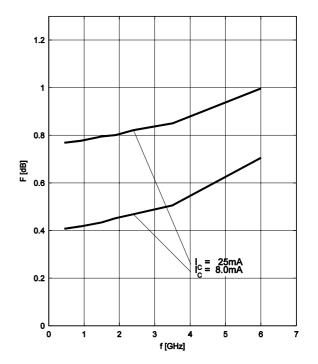
Minimum noise figure $NF_{min} = f(I_C)$

 V_{CE} = 3 V, f = parameter

 $Z_{\rm S} = Z_{\rm Sopt}$



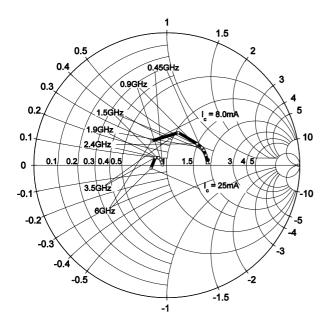
Minimum noise figure $NF_{min} = f(f)$ $V_{CE} = 3V, Z_S = Z_{Sopt}$





Source impedance for min. noise figure vs. frequency

 $V_{\rm CE}$ = 3 V, $I_{\rm C}$ = 8 mA / 25 mA



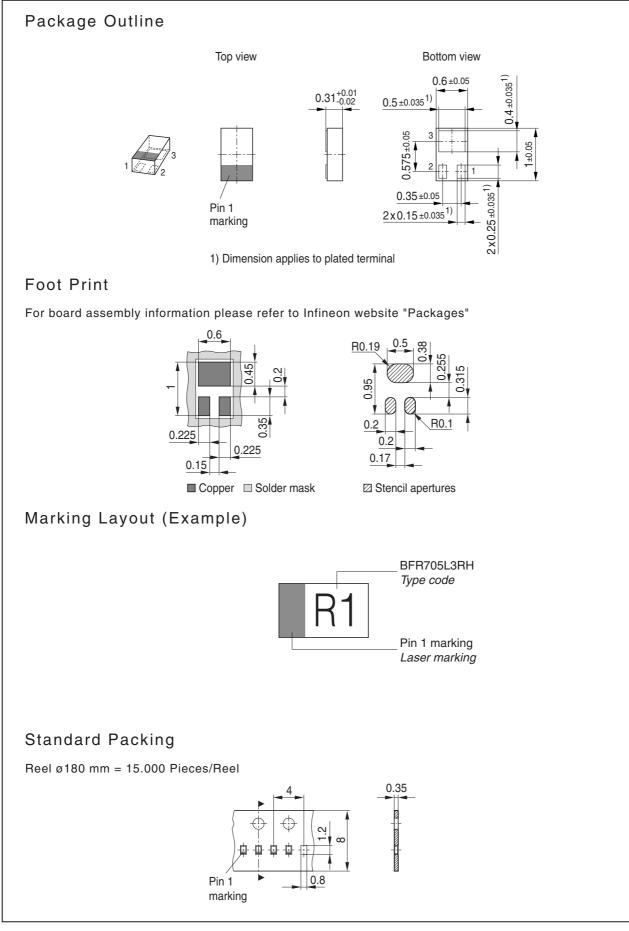


SPICE GP (Gummel-Poon)

For the SPICE Gummel Poon (GP) model as well as for the S-parameters (including noise parameters) please refer to our internet website www.infineon.com/rf.models.

Please consult our website and download the latest versions before actually starting your design. You find the BFR740L3RH SPICE GP model in the internet in MWO- and ADS-format, which you can import into these circuit simulation tools very quickly and conveniently. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. The terminals of the model circuit correspond to the pin configuration of the device. The model parameters have been extracted and verified up to 10 GHz using typical devices. The BFR740L3RH SPICE GP model reflects the typical DC- and RF-performance within the limitations which are given by the SPICE GP model itself. Besides the DC characteristics all S-parameters in magnitude and phase, as well as noise figure (including optimum source impedance, equivalent noise resistance and flicker noise) and intermodulation have been extracted.







Datasheet Revision History: 8 September 2010

This datasheet replaces the revision from 30 March 2007.

The product itself has not been changed and the device characteristics remain unchanged. Only the product description and information available in the datasheet has been expanded and updated.

Previou	Previous Revision 30 March 2007					
Page	Subject (changes since last revision)					
1	AEC Q101 label removed					
2	Typical values for leakage currents included, values for maximum leakage					
	currents reduced					
4	SPICE model parameters shifted from datasheet to the internet simulation data					
	section					
6,7	NFmin and GammaOpt Charts updated					





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